Searcn Notes				

Applica	tion/Control No.	Applicant(s)/Patent under Reexamination FUKUSHIMA ET AL.	
10/006	794		
Examin	er	Art Unit	
A1	des C. Chidea	2042	

	SEARCHED			
Class	Subclass	Date	Examiner	
438	758	8/18/05	Ae	
438	780			
422	250			
422	255.17			
abo	detat	2/16/06	Ac	
			<del></del>	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
438	758	2/16/06	AC	
438	780			
427	250			
427	255.17	- \ -	-	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
West (2e1 Withs)	2/16/06	De	